Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | WANG ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0009642	01-2004	Yoo et al.	438/257
	В	US-2003/0185071	10-2003	Yoshino, Akira	365/200
	С	US-6,255,230	07-2001	lkakura et al.	438/765
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-			·
	J	US-			
	К	US-			
	۲,	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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